

Notice of References Cited	Application/Control No. 10/675,224		Applicant(s)/Patent Under Reexamination GRUN ET AL.	
	Examiner Elizabeth A. Bolden		Art Unit 1755	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	C	US-5,219,801	06-1993	Shorrock et al.	501/65
*	D	US-6,162,749	12-2000	Brocheton et al.	501/13
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	U	Derwent Abstract 1977-49555Y, abstract of JP 52-66512 A.
	V	Derwent Abstract 1987-268123, abstract of JP 62-187141 A.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.